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APPLICATION NO.	F	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/806,750	_	03/22/2004	Todd Peterson	11032-044-999	2424	
20583	7590	04/19/2005		EXAMINER		
JONES DA			PRITCHETT, JOSHUA L			
	222 EAST 41ST ST NEW YORK, NY 10017			ART UNIT	PAPER NUMBER	
	·			2872		
				DATE MAILED: 04/19/2009	DATE MAILED: 04/19/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	(m)
	10/806,750	PETERSON ET AL.	
Office Action Summary	Examiner	Art Unit	
	Joshua L. Pritchett	2872	
The MAILING DATE of this communication ap Period for Reply	pears on the cover sheet w	ith the correspondence address	s
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a rep If NO period for reply is specified above, the maximum statutory period. - Failure to reply within the set or extended period for reply will, by statut Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	136(a). In no event, however, may a plug within the statutory minimum of thir will apply and will expire SIX (6) MON e, cause the application to become Al	reply be timely filed ty (30) days will be considered timely. NTHS from the mailing date of this commun BANDONED (35 U.S.C. § 133).	nication.
Status			
1) Responsive to communication(s) filed on 24.	lanuary 2005		
	s action is non-final.		
Since this application is in condition for allows closed in accordance with the practice under	ance except for formal mat		rits is
Disposition of Claims			
4) ☐ Claim(s) 1-8,14-16,18,19 and 32-35 is/are pe 4a) Of the above claim(s) is/are withdra 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-8,14-16,18,19 and 32-35 is/are rej 7) ☐ Claim(s) is/are objected to. 8) ☐ Claim(s) are subject to restriction and/	ected.		
Application Papers			
9) ☐ The specification is objected to by the Examin 10) ☑ The drawing(s) filed on 22 March 2004 is/are: Applicant may not request that any objection to the Replacement drawing sheet(s) including the corre 11) ☐ The oath or declaration is objected to by the E	a) accepted or b) ⊠ obe drawing(s) be held in abeya ction is required if the drawing	nce. See 37 CFR 1.85(a). g(s) is objected to. See 37 CFR 1.	
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreig a) All b) Some * c) None of: 1. Certified copies of the priority documer 2. Certified copies of the priority documer 3. Copies of the certified copies of the pri application from the International Bures * See the attached detailed Office action for a list	nts have been received. nts have been received in A ority documents have beer au (PCT Rule 17.2(a)).	Application No n received in this National Stag	je
Attachment(s)			
1) Notice of References Cited (PTO-892)		Summary (PTO-413)	
Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date Secret and Todomati Office.		(s)/Mail Date Informal Patent Application (PTO-152)

DETAILED ACTION

This action is in response to Amendment filed January 24, 2005. Claims 1 and 32 have been amended and claims 9-13 have been cancelled as requested by the applicant.

Drawings

The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the small volume device must be shown or the feature(s) canceled from the claim(s). No new matter should be entered.

Corrected drawing sheets in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The figure or figure number of an amended drawing should not be labeled as "amended." If a drawing figure is to be canceled, the appropriate figure must be removed from the replacement sheet, and where necessary, the remaining figures must be renumbered and appropriate changes made to the brief description of the several views of the drawings for consistency. Additional replacement sheets may be necessary to show the renumbering of the remaining figures. Each drawing sheet submitted after the filing date of an application must be labeled in the top margin as either "Replacement Sheet" or "New Sheet" pursuant to 37 CFR 1.121(d). If the changes are not accepted by the examiner, the applicant will

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be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1, 4-6, 14-16 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tateiwas (US 5,444,529).

Regarding claim 1, Tateiwa teaches a means for determination of a dynamic property (the property of distribution of particles, col. 1 lines 46-47) of a fluid volume (col. 1 lines 44-45), comprising a means for determining the distribution or location or both (Fig. 2) of at least one light scattering particle (2) in the fluid volume (3) by means for detecting (7) light scattering from the last least one particle (6). Tateiwa lacks specific reference to an array chip, array plate or an array slide. However it is very well known in the art to use an array chip, array plate or array slide for the purpose of inspecting the devices [i.e. the fluid contained in the devices] for unwanted particles or viewing multiple samples.

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Regarding claim 4, Tateiwa teaches probes are present in the fluid volume and the particle distribution is indicative of the distribution of the probes in the fluid volume (col. 2 liens 11-27).

Regarding claim 5, Tateiwa teaches the distribution of probes is on a solid phase surface (1).

Regarding claim 6, Tateiwa teaches the dynamic property is uniformity of drying on a solid surface (col. 2 liens 11-27).

Regarding claims 14-16, Tateiwa teaches a plurality of features and has deposited on each feature a volume of 10pL to 2 microliters (3).

Claims 2, 3, 7, 8, 18, 32 and 33 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tateiwa in view of Webb (US 4,385,830).

Regarding claims 2 and 32, Tateiwa teaches the invention as claimed but lacks reference to flow rate. Webb teaches a measured dynamic fluid property of flow rate (Fig. 7). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwa invention measure flow rate as taught by Webb for the purpose of determining the effects of flow rate on particles suspended in a fluid volume.

Regarding claim 3, Tateiwa teaches the invention as claimed but lacks reference to measuring particle distribution. Webb teaches measuring particle distribution in a fluid volume (Fig. 8; col. 14 lines 3-7). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwas invention include the means for measuring Application/Control Number: 10/806,750

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particle distribution as taught by Webb for the purpose of determining the concentration gradients of particles suspended in a fluid volume.

Regarding claim 7, Tateiwa teaches the invention as claimed but lacks reference to measuring flow pattern. Webb teaches measuring flow pattern in a device or portion of a device (16), the device being an article of manufacture including one or more channels or reservoirs (col. 5 line 46). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwas invention include the means for measuring flow pattern as taught by Webb for the purpose of determining the impact of flow patterns on particles suspended in a fluid volume.

Regarding claim 8, Tateiwa teaches the invention as claimed but lacks reference to measuring fluid mixing. Webb teaches measuring fluid mixing in one or more portions of the device or through the entire device (16, 24 and 26), the portions being selected from a group consisting of a mixing chamber, a port, a flow channel (col. 5 line 46), a pump, a valve and a flow channel intersection. It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwas invention include the means for measuring fluid mixing as taught by Webb for the purpose of determining the concentration gradients of particles suspended in a fluid volume.

Regarding claims 18 and 33, Tateiwa teaches the invention as claimed but lacks reference to one particle comprising a plurality of distinguishable particles. Webb teaches a particle comprising a plurality of distinguishable particles (col. 4 liens 58-68). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the

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Tateiwas invention include the particle comprised of a plurality of distinguishable particles as taught by Webb for the purpose of determining the composition of the particle.

Claim 19 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tateiwa in view of Webb as applied to claim 18 above, and further in view of Dittrich (US 3,738,759).

Tateiwa in combination with Webb teaches the invention as claimed but lacks reference to the use of fluids from two different sources. Dittrich teaches the use of mixing fluids from two different sources (16 and 24). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwa invention include to two different fluid sources of Dittrich for the purpose of observing how particles behave at the interface of the two fluids.

Claims 34 and 35 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tateiwa in view of Webb as applied to claim 32 above, and further in view of McDowell (US 5,905,568).

Tateiwa in combination with Webb teaches the invention as claimed but lacks reference to the use of flow tracers and a plurality of portions. McDowell teaches the use of a plurality of portions for flow rates (16). McDowell further teaches the use of flow tracers to detect flow (Fig. 4). It would have been obvious to a person of ordinary skill in the art at the time the invention was made to have the Tateiwa invention include the flow tracers and plurality of portions of McDowell for the purpose of accurately and precisely measuring the flow from different areas to determine the forces exerted on the particles at different locations in the fluid volume.

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Response to Arguments

Applicant's arguments filed January 24, 2005 have been fully considered but they are not

persuasive.

On page 6 of Amendment applicant argues that the basis for motivation to include the

claimed small volume devices in the Tateiwa invention have no basis for motivation in the cited

reference. The applicant is reminded that the motivation to combine the invention does not have

to come explicitly from the prior art of record but may arise from the knowledge of one of

ordinary skill in the art. In this case one of ordinary skill in the art would recognize the

advantages the use of array chips, array plates and array slides and be motivated to add one of

these small volume devices to the Tateiwa invention for the purpose of inspecting the devices for

any unwanted particles.

Conclusion

Applicant's amendment necessitated the new ground(s) of rejection presented in this

Office action. Accordingly, THIS ACTION IS MADE FINAL. See MPEP § 706.07(a).

Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE

MONTHS from the mailing date of this action. In the event a first reply is filed within TWO

MONTHS of the mailing date of this final action and the advisory action is not mailed until after

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final action.

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the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Joshua L. Pritchett whose telephone number is 571-272-2318.

The examiner can normally be reached on Monday - Friday 7:00 - 3:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Drew A. Dunn can be reached on 571-272-2312. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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DHEW A. DUNN SUPERVISORY PATENT EXAMINER